Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | SRIDHAR ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | Α | US-2004/0113732 A1 | 06-2004 | Delamare et al. | 335/229 |
| * | В | US-6,734,770 B2 | 05-2004 | Aigner et al. | 335/78 |
| * | C | US-6,734,513 B2 | 05-2004 | Seki et al. | 257/422 |
| * | D | US-6,633,212 B1 | 10-2003 | Ruan et al. | 335/78 |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | ı | US- | | | |
| | J | US- | | | - |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification | |
|---|---|--|-----------------|---------|------|----------------|--|
| | N | | | | | | |
| | 0 | | | | | • | |
| | Р | | | | | | |
| | Q | | | | | | |
| | R | | | | | | |
| | s | | | | | | |
| | Т | | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | ٦ | |
| | > | |
| | W | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.